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		10/562,175	13004/3
LIST OF PATENTS AN	D PUBLICATIONS FOR	FILING DATE	GROUP ART UNIT
APPLICANT'S INFORMATION	N DISCLOSURE STATEMENT	March 2, 2007	1645
(use several sheets if necessary)	APPLICANT(S): Peter Jo	ohn Hastwell et al.	CONFIRMATION NO.
(use several silects if flecessary)	AFF LIGARITO). FELET JOHIT HASIWEII EL AL.		1324

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	B1	6,184,608	02/06/2001	Cabuz et al.		
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	B7	WO 02/031067 A1	04/17/2003	PCT		
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	B10	WO 02/25936 A2	03/28/2002	PCT		
	B11	JP04/086602	03/19/1992	Japan		Yes

EXAMINER INITIAL		OTHER ART – NON PATENT LITERATURE DOCUMENTS is name of author, title of the article (when appropriate), title of the item (book, magazine, journal, serial, sium, catalog, etc.), date page(s), volume-sisue number(s), publisher, city and/or country where published.
	B12	Michael G. Steward et al., "NanoXerography: The Use of Electrostatic Forces to Pattern Nanoparticles", Proceedings of the 2003 NSF Design, Service and Manufacturing Grantees
		and Research Conference, 7 pgs.

EXAMINER	/Chun-Cheng Wang/	DATE CONSIDERED	03/18/2010

EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

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